Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/637,662	ASAO, YOSHIAKI	
Examiner	Art Unit	
Thinh T Nauven	2818	

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	295	8/1/2005	TTN
257	421	8/1/2005	TTN
257	208	8/1/2005	TTN

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
257`	295	8/1/2005	TTN
east	PUB	8/1/2005	TTN

(INCLUDING SEAF	RCH STRATEGY	<u>^) </u>
	DATE	EXMR
EAST .	8/1/2005	TTN
*		

Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/637,662	ASAO, YOSHIAKI	
Examiner	Art Unit	
Thinh T Nauven	2818	

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	295	8/1/2005	TTN
257	421	8/1/2005	TTN
257	208	8/1/2005	TTN

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
257`	295	8/1/2005	TTN
east	PUB	8/1/2005	TTN
(In	Ceferen	eú)	
	0		

SEARCH NO (INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
EAST	8/1/2005	TTN	